



Industrial Plastic Optocouplers SO8 Package Mechanical and Environmental Testing

Description

The reliability data in this document includes Broadcom reliability test data from the reliability tests done on this product family. All of these products use similar processes and materials. The data in Table 1 and Table 2 reflects actual test data for the devices. Before stress, all devices are preconditioned at MSL 1 using a solder reflow process (260°C peak temperature) and 20 temperature cycles (-55°C to +125°C, 15-minute dwell, 1-minute transfer). This data is taken from testing on Broadcom® devices using internal Broadcom processes, material specifications, design standards, and statistical process controls.

NOTE: This data is not transferable to other manufacturer's similar part types.

Definition of Failure

Abnormal resistance (meaning an open or short failure) is the definition of failure in this data sheet. Specifically, failure occurs when the device fails contact resistance either high or low, or both, and when the device experiences abnormal leakages, or both.

Reliability Testing

Broadcom subjects the devices to a series of reliability tests, including environmental, mechanical, and electrical tests, to ensure that the product meets the intended reliability expectations. The tables provided in this data sheet show the results of reliability testing conducted by Broadcom over a period of time as shown in the test conditions.

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Table 1: Mechanical Tests (Testing Done on a Constructional Basis)

Test Name	Reference Standard	Test Conditions	Units Tested	Units Failed
Temperature Cycling	JESD-A104	–55°C to +125°C	3209	0
		Transfer = 1 minute		
		Dwell = 15 minutes		
		1000 cycles		
Solderability	JESD-B102	8 hours steam aging (93°C),	120	0
(RoHS Condition)		followed by solder dip		
		(260°C, 5 seconds)		
Physical Dimensions	JESD-B100	Conformance to data sheet package	290	0
		drawings		
Preconditioning	J-STD-20	As per reference standard	6203	0
	JA113	(to conform to MSL 1)		

Table 2: Environmental Tests (Testing Done on a Constructional Basis)

Test Name	Reference Standard	Test Conditions	Units Tested	Units Failed
Temperature-Humidity-Bias	JESD-A101	T _A = 85°C, RH = 85%	1060	0
		Biased		
		Time = 1000 hours		
Highly Accelerated Stress Test (HAST)	JESD-A110	T _A = 130°C, RH = 85%	298	0
		Biased		
		Time = 96 hours		
Unbiased HAST	JESD-A118	T _A = 130°C, RH = 85%	856	0
		Unbiased		
		Time = 96 hours		
Autoclave	JESD-A102	T _A = 121°C, RH = 100%	639	0
		Unbiased		
		Time = 96 hours		
High Temperature Bake	JESD-A103	T _A = 150°C	892	0
		Unbiased		
		Time = 1000 hours		

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